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Dependable Texas Instruments Quality and Reliability

description

These latches are ideally suited for use as temporary storage for binary information between processing units and input/output or indicator units. Information present at a data (D) input is transferred to the Q output when the enable (G) is high and the Q output will follow the data input as long as the enable remains high. When the enable goes low, the information (that was setup at the data input at the time the transition occurred) is retained at the Q output until the enable is permitted to go high.

These circuits are completely compatible with all popular TTL families. All inputs are diode-clamped to minimize transmission-line effects and simplify system design. Typical power dissipation is 40 milliwatts per latch.

The SN54100 is characterized for operation over the full military temperature range of -55° to 125° C; the SN74100 is characterized for operation from 0°C to 70°C.

logic diagram (each latch)



schematic (each latch)

SN74100 J OR N PACKAGE											
(TOP	VIEW	0								
-		т́-ъ	_								
NC[11 C	24	_l∨cc								
1D1	2	23]1C								
1D2[3	22]1D3								
102	4	21]1D4								
101	5	20]1Q4								
NC	6	19]1Q3								
GND	7	18	203								
201	8	17	204								
202	9	16]2D4								
2D2	10	15]2D3								
2D1	11	14]ис								
2C 🗌	12	13]NC								

SN54100 ... J OR W PACKAGE

NC-No internal connection

FUNCTION TABLE (Each Latch)									
INP	UTS	ουτ	PUTS						
D	G	Q	ā						
L	н	L	н						
н	н	н	L						
х	L	00	ā0						

H = high level, X = irrelevant Ω_0 = the level of Q before the high-to-low transition of G





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TYPES SN54100, SN74100 8-BIT BISTABLE LATCHES

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)						•			•	•	•		•					7 V
Input voltage			•		۰.			•			•				•	•		5.5 V
Interemitter voltage (see Note 2)			•		•					•						•		5.5 V
Operating free-air temperature range: SN54100		•													5	5°	C to	125°C
SN74100																0	°C1	to 70°C
Storage temperature range	•		•					•		•	•				-6	5°	C to	150°C

NOTES: 1. Voltage values, except interemitter voltage, are with respect to network ground terminal.

This is the voltage between two emitters of a multiple emitter input transistor. For this circuit, this rating applies between the enable and D inputs of any latch.

recommended operating conditions

		SN5410	0				
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}	4.5	5	5.5	4.75	5	5.25	v
High-level output current, IOH			-400			-400	μA
Low-level output current, IOL			16		_	16	mA
Width of enabling pulse, t _w	20			20			ns
Setup time, t _{su}	20			20	_		ns
Hold time, t _h	5			5			ns
Operating free-air temperature, TA	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITIONS [†]				түр‡	MAX	UNIT
VIH	High-level input voltage					2			v
VIL	Low-level input voltage							0.8	V
VIK	Input clamp voltage		V _{CC} = MIN,	= ۱۱	-12 mA			-1.5	V
∨он	VOH High-level output voltage				= 2 V, = -400 μA	2.4	3.4		v
VOL	Low-level output voltage	V _{CC} = MIN, V _{IL} = 0.8 V,	VIF IOL	= 2 V, = 16 mA		0.2	0.4	v	
1	Input current at maximum input voltage		V _{CC} = MAX,	VI -	= 5.5 V			1	mA
Чн	High-level input current	D input C input	V _{CC} = MAX,	۷I	= 2.4 V			80 320	μA
41	Low-level input current	D input C input	V _{CC} = MAX,	۷I	= 0.4 V			3.2 12.8	mA
1	Chart aircuit autout auroat 8		VMAX	_	SN54100	-20		-57	
'OS			•	SN74100	-18		-57		
1-0	Supply ourset	V _{CC} = MAX,	SN54100			64	92		
'CC	Supply cuttent	See Note 3		SN74100		64	106		

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡]All typical values are at $V_{CC} = 5 V$, $T_A = 25$ °C.

\$ Not more than one output should be shorted at a time.

NOTE 3: ICC is tested with all inputs grounded and all outputs open.

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TTL DEVICES

TYPES SN54100, SN74100 8-BIT BISTABLE LATCHES

switching characteristics, V_{CC} = 5 V, T_A = 25° C

PARAMETER¶	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	түр	МАХ	UNIT
tPLH		0 .	$C_{1} = 15 \text{ pF}$		16	30	
tPHL			$\mathbf{C}_{L} = 15 \mathbf{\mu}_{L},$ $\mathbf{B}_{L} = 400 \Omega$		14	25	115
tPLH	<u> </u>	0			16	30	
tPHL	Ĭ	<u> </u>	366 10016 4		7	15	115

¶ t_{PLH} = propagation delay time, low-to-hgih-level output t_{PHL} = propagation delay time, high-to-low-level output NOTE 4: Load circuits and voltage waveforms are the same as those shown for the '75, '77, 'L75, and 'L77.



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